

<b>Notice of References Cited</b>	Application/Control No. 10/054,207	Applicant(s)/Patent Under Reexamination KERMAREC ET AL.	
	Examiner Joseph E. Avellino	Art Unit 2143	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,353,596 B1	03-2002	Grossglauser et al.	370/256
	B	US-2002/0099937 A1	07-2002	Tuomenoksa, Mark	713/153
	C	US-6,535,507 B1	03-2003	Li et al.	370/356
	D	US-2003/0048779 A1	03-2003	Doherty et al.	370/389
	E	US-2003/0108051 A1	06-2003	Bryden et al.	370/395.54
	F	US-6,587,467 B1	07-2003	Morgenstern et al.	370/399
	G	US-6,636,516 B1	10-2003	Yamano, Shigeki	370/395.52
	H	US-6,654,347 B1	11-2003	Wiedeman et al.	370/241
	I	US-6,693,878 B1	02-2004	Daruwalla et al.	370/235
	J	US-6,789,121 B2	09-2004	Lamberton et al.	709/227
	K	US-2004/0202157 A1	10-2004	Chase et al.	370/389
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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